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Privacy and Security in Blockchain-Based Internet of Things (IoT)

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Message from the Guest Editor

This Special Issue (SI) of *Electronics* solicits innovative and robust cryptographic techniques and security protocols that are suitable for IoT environments with blockchain technology. It also provides an opportunity for discussions to explore new challenges and frontiers in the various application fields of IoT security and privacy under blockchain technologies.

The topics of interest include, but are not limited to:

- Security and privacy in IoT
- Decentralized IoT architecture
- Privacy-preserving systems with smart contracts
- IoT security using zero-knowledge proof
- Cryptographic protocols for IoT
- IoT systems using decentralized identifier (DID) technologies

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SpecialIssue

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Message from the Editor-in-Chief

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